

**Notice of References Cited**

Application/Control No.

09/883,621

Applicant(s)/Patent Under  
Reexamination  
HUFFMAN, JOHN W.

Examiner

Kimberly D. Nguyen

Art Unit

2876

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,266,944 /	11-1993	Carroll et al.	340/825.36
	B	US-5,587,740 /	12-1996	Brennan, James M.	348/373
	C	US-5,993,001 /	11-1999	Bursell et al.	351/212
	D	US-4,145,715 /	03-1979	Clever, Eric C.	348/150
	E	US-6,128,398 /	10-2000	Kuperstein et al.	382/118
	F	US-5,151,945 /	09-1992	Lee et al.	382/103
	G	US-6,366,311 /	04-2002	Monroe, David A.	348/148
	H	US-3,988,533 /	10-1976	Mick et al.	348/155
	I	US-6,213,395 /	04-2001	Dejaeger et al.	235/383
	J	US-6,343,739 /	02-2002	Lippert, Kurt J.	235/383
	K	US-6,504,481 /	01-2003	Teller, David M.	340/572.1
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.